



IEC QUALITY ASSESSMENT SYSTEM (IECQ)

covering Electronic Components,
Assemblies, Related Materials and Processes

For rules and details of the IECQ visit www.iecq.org

Schedule of Scope to Certificate of Approval

Independent Testing Laboratory

IECQ Certificate No.: IECQ-L JQAJP 13.0001

CB Certificate No.: JQAQ0001-001-T

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Type of Components

IEC 60384-1 (Fixed capacitor)

IEC 60115-1 (Fixed register)

IEC 62326-1 (Printed circuit board)

ENVIRONMENTAL TEST

IEC 60068-2-1 (Test A: Cold)

IEC 60068-2-2 (Test B: Dry heat)

IEC 60068-2-14 (Test N: Change of temperature)

IEC 60068-2-30 (Test Db: Damp heat, cyclic (12+12-hour cycle))

IEC 60068-2-38 (Test Z/AD: Composite temperature/humidity cyclic test)

IEC 60068-2-66 (Test Cx: Damp heat, steady state (unsaturated pressurized vapour))

IEC 60068-2-78 (Test Cab: Damp heat, steady state)

MECHANICAL TEST

IEC 60068-2-6 (Test Fc: Vibration (sinusoidal))

This schedule is only valid in conjunction with the referenced Certificate of Approval

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